



**EXPEDITED PROCEDURE – EXAMINING GROUP 2857**

**PATENT**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant: Sergey A. Velichko et al. Examiner: Craig Steven Miller  
Serial No.: 09/834,751 Group Art Unit: 2857  
Filed: April 13, 2001 Docket No.: 303.750US1  
Title: CONCURRENT CONTROL OF SEMICONDUCTOR PARAMETRIC  
TESTING

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**AMENDMENT AND RESPONSE TO ADVISORY ACTION**  
**UNDER 37 C.F.R. 1.116**

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Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

In response to the Advisory Action mailed February 4, 2005, please consider the following: